

Supplementary Materials

Growth and Thermal Conductivity Study of CuCr₂Se₄-CuCrSe₂ Hetero-Composite Crystals

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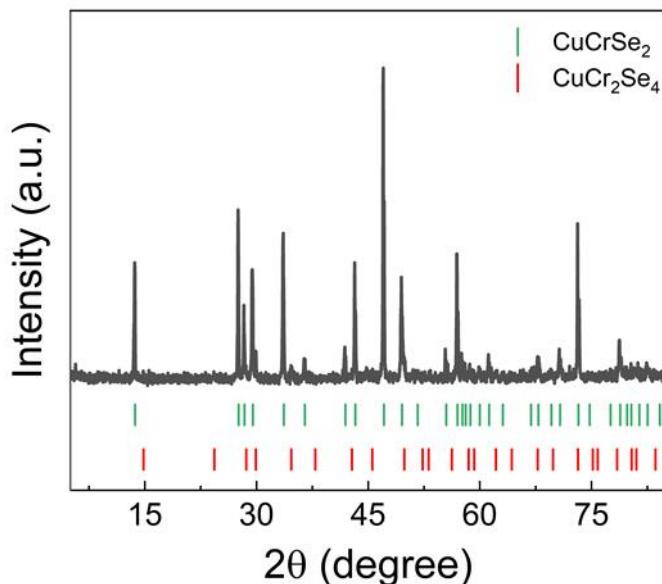


Figure S1. XRD pattern of synthesized CuCrSe₂ polycrystalline powder.

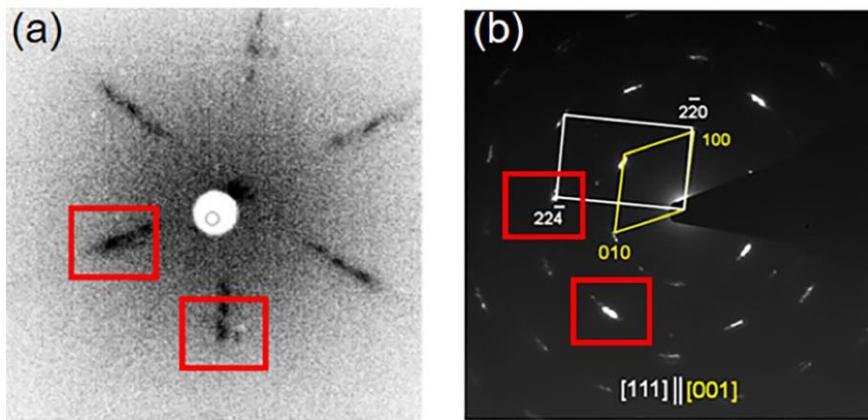


Figure S2. (a) The Laue pattern of composite of CuCrSe_2 and CuCr_2Se_4 . The red rectangles highlight the broadening and splitting reflection spots that consist of the reflection spots of CuCrSe_2 and CuCr_2Se_4 , compared with electron diffraction (two red rectangle) shown in (b). Based on this comparison, though the resolution of Laue pattern is poor, the orientation relationship between CuCrSe_2 and CuCr_2Se_4 determined through electron diffraction is correct.